**Product data sheet** 

# 1. General description

Dual Silicon Carbide Schottky diode in a TO247 plastic package, designed for high frequency switched-mode power supplies.



### 2. Features and benefits

- New 6th Generation Technology
- Low Forward Voltage Drop
- Low Reverse Leakage Current
- High Forward Surge Capability IFSM
- · Reduced losses in associated MOSFET
- Reduced EMI
- · Reduced cooling requirements
- RoHS compliant

# 3. Applications

- Power factor correction
- Telecom / Server SMPS
- UPS
- PV inverter
- PC Silverbox
- LED / OLED TV
- Motor Drives

### 4. Quick reference data

#### Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values			Unit
Absolute	maximum rating						
$V_{RRM}$	repetitive peak reverse voltage				650		V
I <sub>O(AV)</sub>	limiting average forward current	$δ = 0.5$ ; square-wave pulse; $T_{mb} \le 139$ °C; both diodes conducting; Fig. 1; Fig. 2; Fig. 3		30		А	
T <sub>j</sub>	junction temperature			-55 to 175		°C	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
V <sub>F</sub>	forward voltage	$I_F = 15 \text{ A}; T_j = 25 ^{\circ}\text{C}; \text{ per diode}; Fig. 5$		-	1.26	1.40	V
		I <sub>F</sub> = 15 A; T <sub>j</sub> = 150 °C; per diode; <u>Fig. 5</u>		-	1.35	1.55	V
Dynamic	characteristics						
$Q_r$	recovered charge	$I_F = 15 \text{ A}$ ; $dI_F/dt = 500 \text{ A/}\mu\text{s}$ ; $V_R = 400 \text{ V}$ ; $T_j = 25 ^{\circ}\text{C}$ ; per diode; Fig. 7		-	36	-	nC

# 5. Pinning information

### **Table 2. Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode		
2	K	cathode		A1
3	A2	anode		K
mb	mb	mounting base; connected to cathode	1 2 3	sym125

# 6. Ordering information

### **Table 3. Ordering information**

Type number	Package name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WNSC6D30650CW	TO247	WNSC6D30650CW6Q	Tube	30	TO247N	20-July-2016

# 7. Marking

### **Table 4. Marking codes**

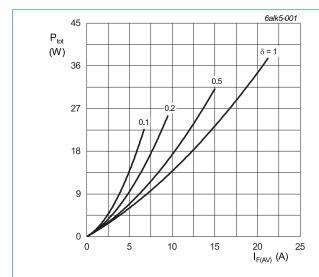
Type number	Marking codes
WNSC6D30650CW	WNSC6D 30650CW

# 8. Limiting values

### **Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
$V_{RRM}$	repetitive peak reverse voltage			650	V
$V_{RWM}$	crest working reverse voltage			650	V
$V_R$	reverse voltage	DC		650	V
I <sub>O(AV)</sub>	limiting average forward current	δ = 0.5; square-wave pulse; T <sub>mb</sub> ≤ 139 °C; both diodes conducting; <u>Fig. 1</u> ; <u>Fig. 2</u> ; <u>Fig. 3</u>		30	А
I <sub>FRM</sub>	repetitive peak forward current	$\delta$ = 0.5; t <sub>p</sub> = 25 μs; T <sub>mb</sub> ≤ 141 °C; square-wave pulse; per diode		30	А
I <sub>FSM</sub>	non-repetitive peak forward current	$t_p$ = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode		120	А
		$t_p$ = 10 $\mu$ s; $T_{j(init)}$ = 25 °C; square-wave pulse; per diode		900	Α
l <sup>2</sup> t	I <sup>2</sup> t for fusing	sine-wave pulse; $T_{j(init)} = 25 \text{ °C}$ ; $t_p = 10 \text{ ms}$		72	A <sup>2</sup> s
T <sub>stg</sub>	storage temperature			-55 to 175	°C
T <sub>j</sub>	junction temperature			-55 to 175	°C



 $I_{F(AV)} = I_{F(RMS)} \times \sqrt{\delta}$   $V_0 = 1.032 \text{ V}; \text{ R}_s = 0.0348 \Omega$ 

Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values; per diode

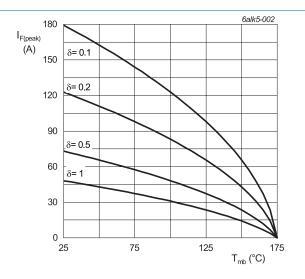
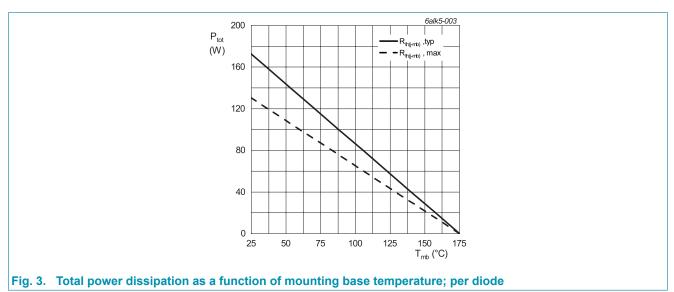


Fig. 2. Current derating as a function of mounting base temperature; per diode



## 9. Thermal characteristics

**Table 6. Thermal characteristics** 

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance	per diode; Fig. 4		-	0.87	1.15	K/W
	from junction to mounting base	both diodes conducting		-	-	0.55	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient free air	in free air		-	60	-	K/W

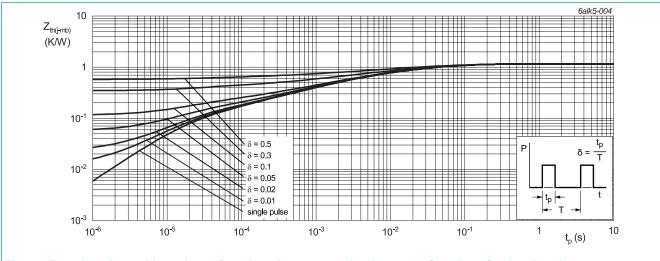
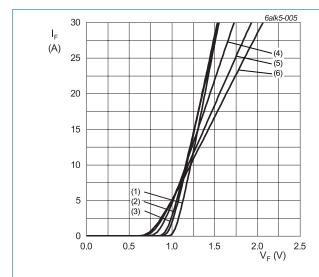


Fig. 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

# 10. Characteristics

Table 7 Characteristics

Table 7. Ci	naracteristics						
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	aracteristics						
$V_{F}$	forward current	I <sub>F</sub> = 15 A; T <sub>j</sub> = 25 °C; per diode; <u>Fig. 5</u>		-	1.26	1.40	V
		I <sub>F</sub> = 15 A; T <sub>j</sub> = 150 °C; per diode; <u>Fig. 5</u>		-	1.35	1.55	V
		I <sub>F</sub> = 15 A; T <sub>j</sub> = 175 °C; per diode; <u>Fig. 5</u>		-	1.40	1.60	V
I <sub>R</sub>	reverse current	$V_R = 650 \text{ V}; T_j = 25 ^{\circ}\text{C}; \text{ per diode}; Fig. 6$		-	1	80	μA
		V <sub>R</sub> = 650 V; T <sub>j</sub> = 175 °C; per diode; <u>Fig. 6</u>		-	25	320	μA
Dynamic	characteristics						
$Q_r$	recovered charge	$I_F = 15 \text{ A}$ ; $V_R = 400 \text{ V}$ ; $dI_F/dt = 500 \text{ A/}\mu\text{s}$ ; $T_j = 25 \text{ °C}$ ; per diode; Fig. 7		-	36	-	nC
C <sub>d</sub>	diode capacitance	$f = 1 \text{ MHz}$ ; $V_R = 1 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; per diode		-	780	-	pF
		$f = 1 \text{ MHz}; V_R = 300 \text{ V}; T_j = 25 ^{\circ}\text{C}; \text{ per diode}$		-	86	-	pF
		$f = 1 \text{ MHz}$ ; $V_R = 600 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; per diode		-	79	-	pF
E <sub>as</sub>	non-repetitive avalanche energy	$I_R = 7 \text{ A}$ ; L = 5 mH; $T_{j(init)} = 25 ^{\circ}\text{C}$ ; per diode		120	-	-	mJ



 $V_o$  = 1.032 V;  $R_s$  = 0.0348  $\Omega$ 

(1)  $T_j = -55$  °C; typical values

(2)  $T_j = 0$  °C; typical values

(3) T<sub>i</sub> = 25 °C; typical values

(4) T<sub>i</sub> = 100 °C; typical values

(5)  $T_j = 150$  °C; typical values

(6) T<sub>j</sub> = 175 °C; typical values

Fig. 5. Forward current as a function of forward voltage; typical values; per diode

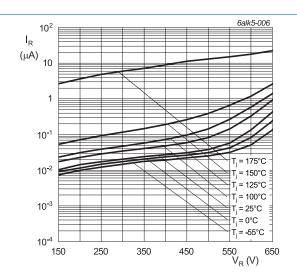


Fig. 6. Reverse leakage current as a function of reverse voltage; typical value; per diode

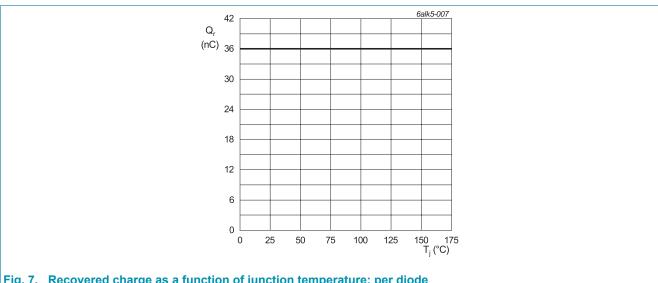
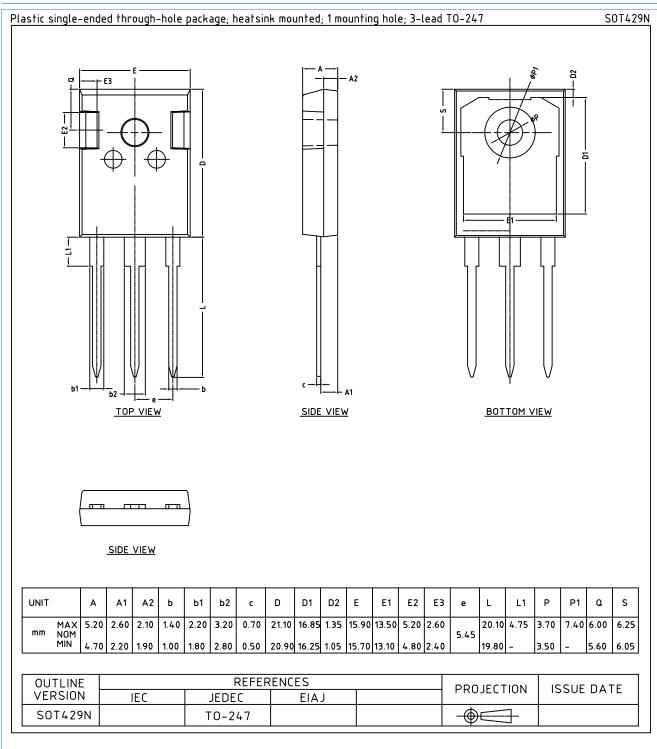


Fig. 7. Recovered charge as a function of junction temperature; per diode

# 11. Package outline



## 12. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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